S	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/394,745	FISHER ET AL.	
Examiner	Art Unit	
Young J. Kim	1637	

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Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Appeal Conference: Gary Benzion (SPE) and Joseph Woitach (SPE)	6/15/2007	YJK